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STL23NM50N

Datasheet — production data

N-channel 500 V, 0.170 Ωtyp., 14 A MDmesh[™] II Power MOSFET in a PowerFLAT[™] 8x8 HV package

Features

Туре	V _{DSS} @ T _{Jmax}	R _{DS(on)} max	I _D
STL23NM50N	550 V	< 0.210 Ω	14 A ⁽¹⁾

- 1. The value is rated according to $R_{thj-case}$
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Applications

Switching applications

Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh[™] technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

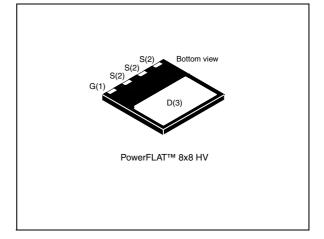


Figure 1. Internal schematic diagram

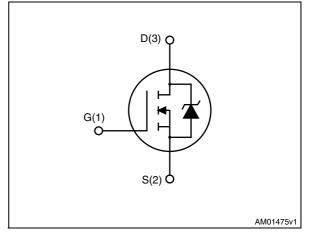


Table 1. Device summary

Order code	Marking	Package	Packaging
STL23NM50N	23NM50N	PowerFLAT™ 8x8 HV	Tape and reel

This is information on a product in full production.

Contents

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuits	8
4	Package mechanical data	9
5	Revision history1	2



1

Absolute maximum ratings

Electrical ratings

Table 2.

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	500	V
V _{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at $T_C = 25 \text{ °C}$	14	А
I _D ⁽¹⁾	Drain current (continuous) at $T_{C} = 100 \text{ °C}$	11	А
I _D ⁽³⁾	Drain current (continuous) at T _{amb} = 25 °C	2.8	Α
I _D ⁽³⁾	Drain current (continuous) at T _{amb} = 100 °C	2.1	А
I _{DM} ^{(1),(2)}	Drain current (pulsed)	56	А
P _{TOT} ⁽³⁾	Total dissipation at $T_{amb} = 25 \degree C$	3	W
P _{TOT} ⁽¹⁾	Total dissipation at $T_C = 25 \ ^{\circ}C$	125	W
I _{AR}	Avalanche current, repetitive or not- repetitive (pulse width limited by T _j max)	4	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25 \text{ °C}, I_D = I_{AR}, V_{DD} = 50 \text{ V}$)	300	mJ
dv/dt ⁽⁴⁾	Peak diode recovery voltage slope	15	V/ns
T _{stg}	Storage temperature	- 55 to 150	°C
Тj	Max. operating junction temperature	150	°C

1. The value is rated according to $\mathrm{R}_{\mathrm{thj-case}}$

2. Pulse width limited by safe operating area

3. When mounted on FR-4 board of inch², 2oz Cu

4. $I_{SD} \leq$ 14 A, di/dt \leq 400 A/µs, V_{DSpeak} \leq V_{(BR)DSS}, V_{DD} = 80% V_{(BR)DSS}

Table 3.Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1	°C/W
R _{thj-amb} ⁽¹⁾	Thermal resistance junction-amb max	45	°C/W

1. When mounted on 1 inch² FR-4 board, 2 oz Cu



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 1 \text{ mA}, V_{GS} = 0$	500			V
I _{DSS}	Zero gate voltage drain current	$V_{DS} = Max rating$ $V_{DS} = Max rating, T_C=125 °C$ $V_{GS} = 0$			1 100	μΑ μΑ
I _{GSS}	Gate-body leakage current	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0$			100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 7 A		0.170	0.210	Ω

Table 4. On /off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 50 V, f = 1 MHz, V _{GS} = 0	-	1330 84 4.8	-	pF pF pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0$ to 400 V	-	210	-	pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 400 V, I_D = 17 A,$ $V_{GS} = 10 V,$ <i>(see Figure 14)</i>	-	45 7 24	-	nC nC nC
R _g	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level=20 mV open drain	-	4.6	-	Ω

1. $C_{oss eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DS}

Sy	ymbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
1	t _{d(on)} t _r	Turn-on delay time Rise time	V _{DD} = 250 V, I _D = 17 A		6.6 19		ns ns
1	t _{d(off)} t _f	Turn-off-delay time Fall time	$R_{G} = 4.7 \Omega V_{GS} = 10 V$ (see Figure 13)	-	71 29	-	ns ns



Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)		-		17 68	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 17 A, V _{GS} = 0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 17 A, di/dt = 100 A/μs V _{DD} = 60 V <i>(see Figure 18)</i>	-	286 3700 26		ns nC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 17 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 60 \text{ V}, \text{ T}_{j} = 150 ^{\circ}\text{C}$ <i>(see Figure 18)</i>	-	350 4800 27		ns nC A

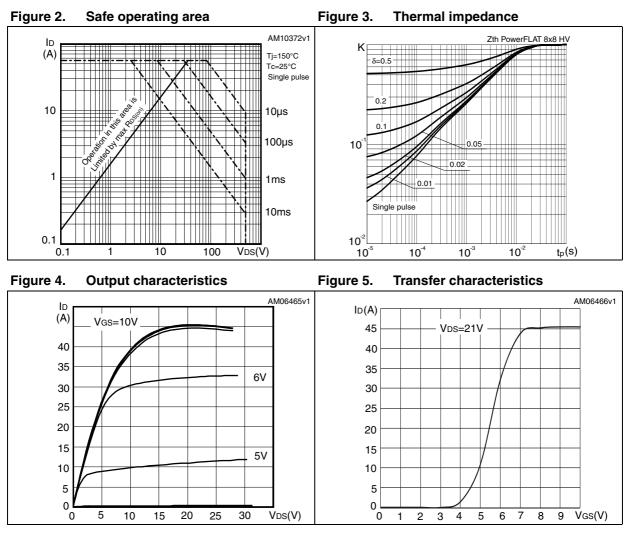
Table 7.Source drain diode

1. Pulse width limited by safe operating area

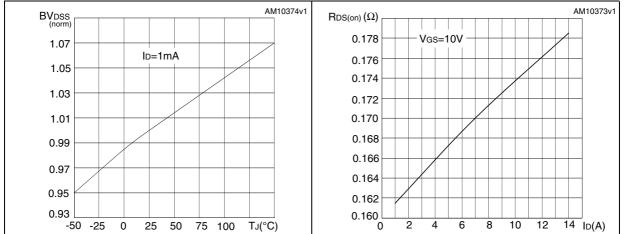
2. Pulsed: pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)







Doc ID 022339 Rev 2



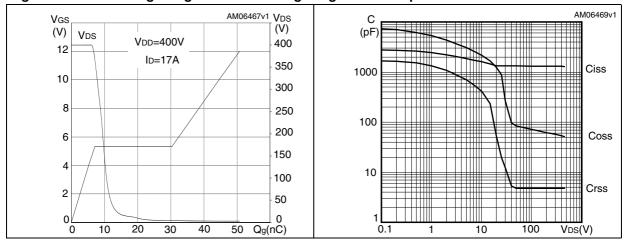
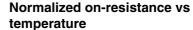


Figure 8. Gate charge vs gate-source voltage Figure 9. **Capacitance variations**

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on-resistance vs vs temperature



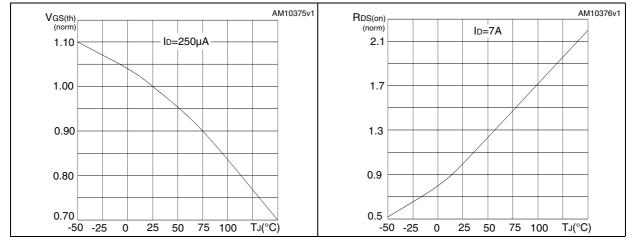
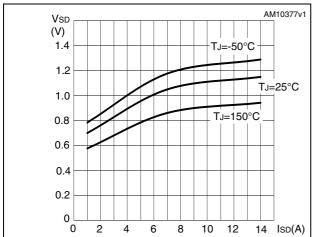


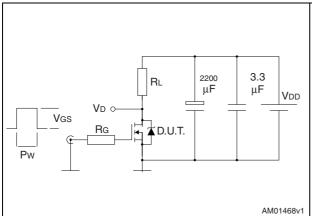
Figure 12. Source-drain diode forward characteristics





3 Test circuits

Figure 13. Switching times test circuit for resistive load



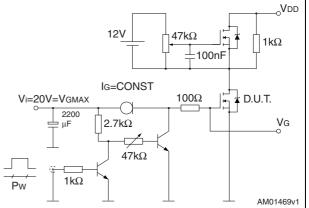
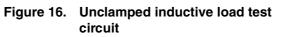
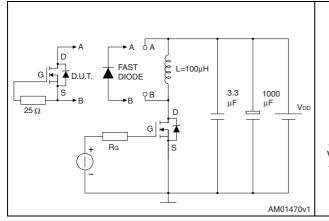


Figure 14. Gate charge test circuit

Figure 15. Test circuit for inductive load switching and diode recovery times





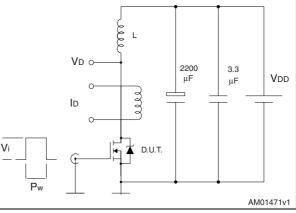
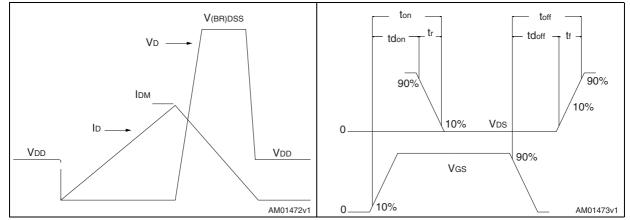


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform





4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Dim		mm	
Dim. –	Min.	Тур.	Max.
A	0.80	0.90	1.00
A1	0.00	0.02	0.05
b	0.95	1.00	1.05
D		8.00	
E		8.00	
D2	7.05	7.20	7.30
E2	4.15	4.30	4.40
е		2.00	
L	0.40	0.50	0.60
aaa		0.10	
bbb		0.10	
ccc		0.10	

Table 8. PowerFLAT™8x8 HV mechanical data



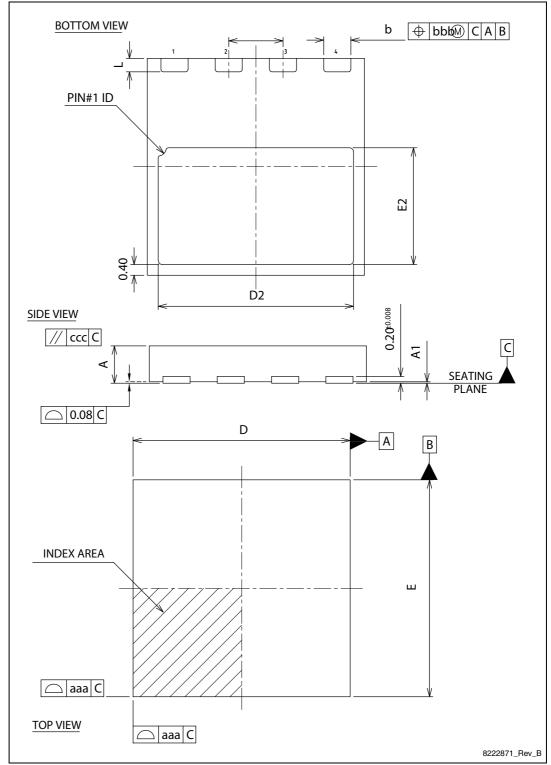


Figure 19. PowerFLAT™ 8x8 HV drawing mechanical data

Doc ID 022339 Rev 2



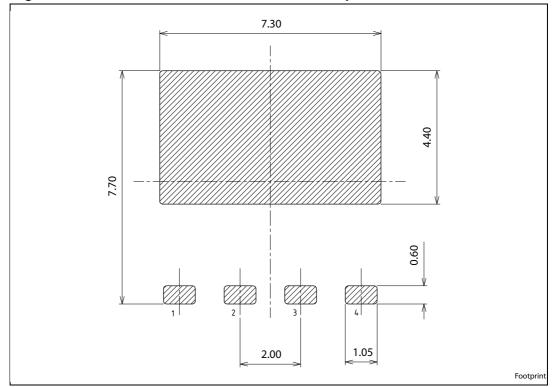


Figure 20. PowerFLAT[™] 8x8 HV recommended footprint



5 Revision history

Table 9. Document revision history	evision history
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Date	Revision	Changes
10-Oct-2011	1	First release.
08-Oct-2012	2	Updated title on the cover page. Updated value for dv/dt on <i>Table 2: Absolute maximum ratings</i> . Document status promoted from preliminary to production data.



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